


<b>Search Notes</b>  	<b>Application/Control No.</b>  10593331	<b>Applicant(s)/Patent Under Reexamination</b>  HAYASHI ET AL.
	<b>Examiner</b>  Matthew E Hoban	<b>Art Unit</b>  4116

SEARCHED			
Class	Subclass	Date	Examiner
501	119 +txt	12/19/2007	meh

SEARCH NOTES		
Search Notes	Date	Examiner
See East Search history	12/19/2007	meh
Inventor Search completed in PALM	12/19/2007	meh

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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